Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/729,865	CHEN ET AL.	
Examiner	Art Unit	
VanThu Nguyen	2824	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH	ES STRATEGY	()
	DATE	EXMR
EAST Search	1/5/2006	VTN
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